

16-bit transparent latch (3-State)**74ABT16373B
74ABTH16373B****FEATURES**

- 16-bit transparent latch
- Multiple V_{CC} and GND pins minimize switching noise
- Power-up 3-State
- Live insertion/extraction permitted
- Power-up reset
- 3-State output buffers
- 74ABTH16373B incorporates bus-hold data inputs which eliminate the need for external pull-up resistors to hold unused inputs
- Output capability: +64mA/-32mA
- I_{CCL} = 19 mA maximum
- Latch-up protection exceeds 500mA per JEDEC Std 17
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model

DESCRIPTION

The 74ABT16373B high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

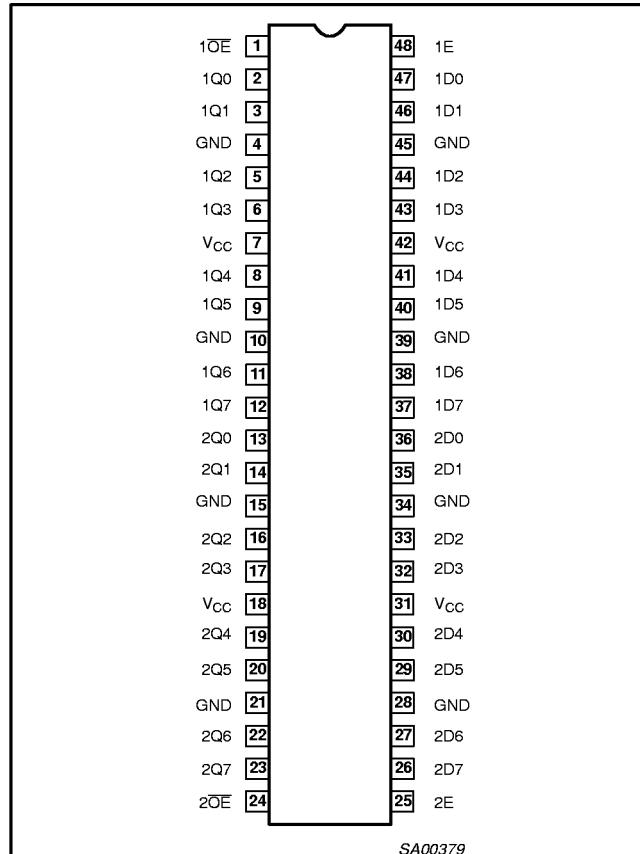
The 74ABT16373B device is a dual octal transparent latch coupled to two sets of eight 3-State output buffers. The two sections of the device are controlled independently by Enable (nE) and Output Enable (nOE) control gates.

The data on each set of D inputs are transferred to the latch outputs when the Latch Enable (nE) input is High. The latch remains transparent to the data inputs while nE is High, and stores the data that is present one setup time before the High-to-Low enable transition.

The 3-State output buffers are designed to drive heavily loaded 3-State buses, MOS memories, or MOS microprocessors. Each active-Low Output Enable (nOE) controls eight 3-State buffers independent of the latch operation.

When nOE is Low, the latched or transparent data appears at the outputs. When nOE is High, the outputs are in the High-impedance "OFF" state, which means they will neither drive nor load the bus.

Two options are available, 74ABT16373B which does not have the bus-hold feature and 74ABTH16373B which incorporates the bus-hold feature.

PIN CONFIGURATION

SA00379

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS $T_{amb} = 25^\circ\text{C}$; GND = 0V	TYPICAL	UNIT
t _{PLH} t _{PHL}	Propagation delay D _n to Q _n	$C_L = 50\text{pF}$; V _{CC} = 5V	2.5 2.0	ns
C _{IN}	Input capacitance	V _I = 0V or V _{CC}	4	pF
C _{OUT}	Output capacitance	V _O = 0V or V _{CC} ; 3-State	7	pF
I _{CCZ}	Quiescent supply current	Outputs disabled; V _{CC} = 5.5V	500	μA
I _{CCL}		Outputs low; V _{CC} = 5.5V	8	mA

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
48-Pin SSOP type III	-40°C to +85°C	74ABT16373B DL	BT16373B DL	SOT370-1
48-Pin TSSOP type II	-40°C to +85°C	74ABT16373B DGG	BT16373B DGG	SOT362-1
48-Pin SSOP type III	-40°C to +85°C	74ABTH16373B DL	BH16373B DL	SOT370-1
48-Pin TSSOP type II	-40°C to +85°C	74ABTH16373B DGG	BH16373B DGG	SOT362-1

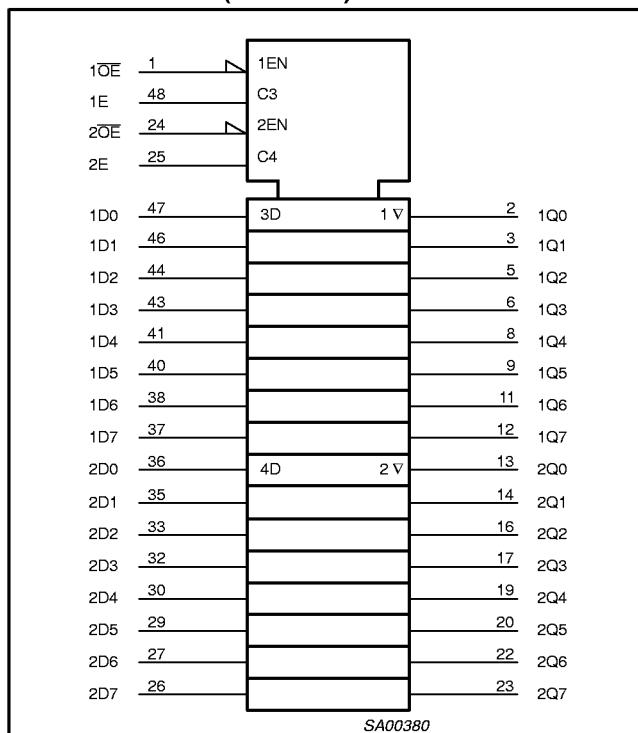
16-bit transparent latch (3-State)

74ABT16373B
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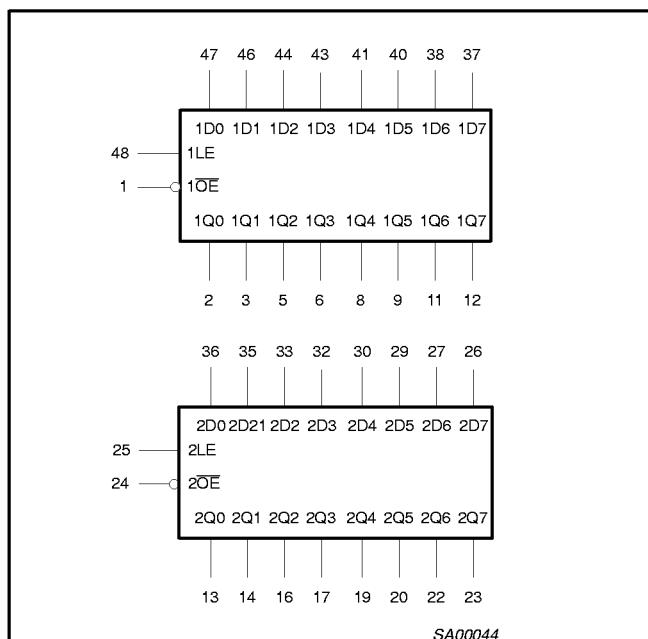
PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
47, 46, 44, 43, 41, 40, 38, 37, 36, 35, 33, 32, 30, 29, 27, 26	1D0 – 1D7 2D0 – 2D7	Data inputs
2, 3, 5, 6, 8, 9, 11, 12, 13, 14, 16, 17, 19, 20, 22, 23	1Q0 – 1Q7 2Q0 – 2Q7	Data outputs
1, 24	1OE, 2OE	Output enable inputs (active-Low)
48, 25	1E, 2E	Enable inputs (active-High)
4, 10, 15, 21, 28, 34, 39, 45	GND	Ground (0V)
7, 18, 31, 42	V _{CC}	Positive supply voltage

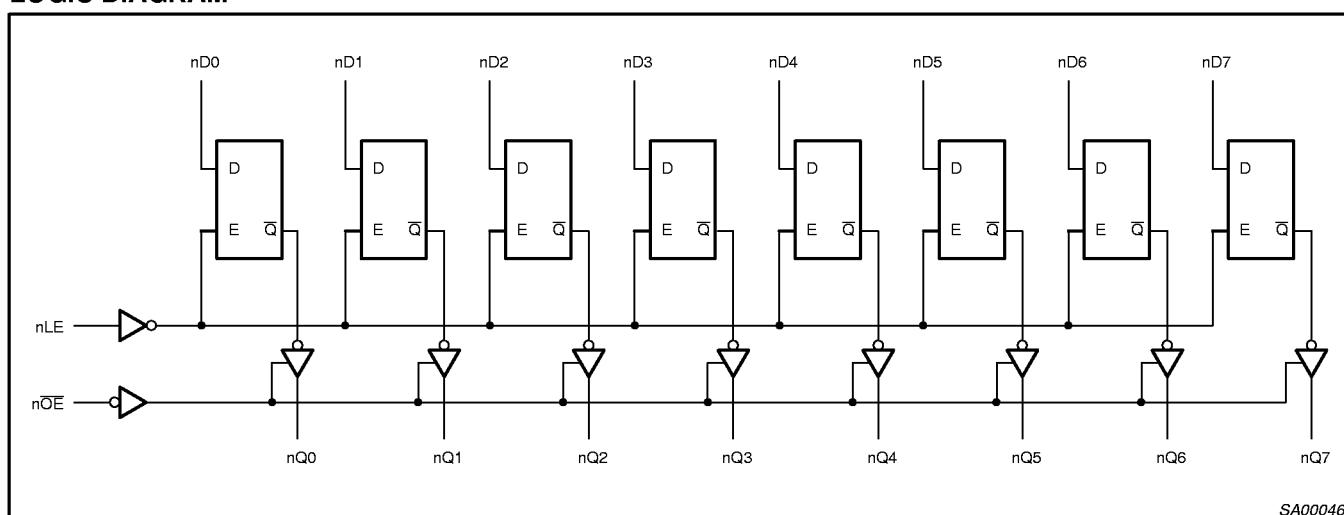
LOGIC SYMBOL (IEEE/IEC)



LOGIC SYMBOL



LOGIC DIAGRAM



16-bit transparent latch (3-State)

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FUNCTION TABLE

INPUTS			INTERNAL REGISTER	OUTPUTS nQ0 – nQ7	OPERATING MODE
nOE	nE	nDx			
L	H	L	L	L	Enable and read register
L	H	H	H	H	
L	↓	i	L	L	Latch and read register
L	↓	h	H	H	
L	L	X	NC	NC	Hold
H	L	X	NC	Z	Disable outputs
H	H	Dn	Dn	Z	

H = High voltage level

h = High voltage level one set-up time prior to the High-to-Low E transition

L = Low voltage level

l = Low voltage level one set-up time prior to the High-to-Low E transition

NC = No change

X = Don't care

Z = High impedance "off" state

↓ = High-to-Low E transition

ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +7.0	V
I _{IK}	DC input diode current	V _I < 0	-18	mA
V _I	DC input voltage ³		-1.2 to +7.0	V
I _{OK}	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	output in Off or High state	-0.5 to +5.5	V
I _{OUT}	DC output current	output in Low state	128	mA
		output in High state	-64	
T _{stg}	Storage temperature range		-65 to 150	°C

NOTES:

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.
- The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS		UNIT
		MIN	MAX	
V _{CC}	DC supply voltage	4.5	5.5	V
V _I	Input voltage	0	V _{CC}	V
V _{IH}	High-level input voltage	2.0		V
V _{IL}	Low-level Input voltage		0.8	V
I _{OH}	High-level output current		-32	mA
I _{OL}	Low-level output current		64	mA
Δt/Δv	Input transition rise or fall rate	0	10	ns/V
T _{tamb}	Operating free-air temperature range	-40	+85	°C

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DC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS					UNIT	
			$T_{amb} = +25^{\circ}\text{C}$			$T_{amb} = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$			
			MIN	TYP	MAX	MIN	MAX		
V_{IK}	Input clamp voltage	$V_{CC} = 4.5\text{V}; I_{IK} = -18\text{mA}$		-0.9	-1.2		-1.2	V	
V_{OH}	High-level output voltage	$V_{CC} = 4.5\text{V}; I_{OH} = -3\text{mA}; V_I = V_{IL} \text{ or } V_{IH}$	2.5	2.9		2.5		V	
		$V_{CC} = 5.0\text{V}; I_{OH} = -3\text{mA}; V_I = V_{IL} \text{ or } V_{IH}$	3.0	3.4		3.0		V	
		$V_{CC} = 4.5\text{V}; I_{OH} = -32\text{mA}; V_I = V_{IL} \text{ or } V_{IH}$	2.0	2.4		2.0		V	
V_{OL}	Low-level output voltage	$V_{CC} = 4.5\text{V}; I_{OL} = 64\text{mA}; V_I = V_{IL} \text{ or } V_{IH}$		0.42	0.55		0.55	V	
V_{RST}	Power-up output voltage ³	$V_{CC} = 5.5\text{V}; I_O = 1\text{mA}; V_I = \text{GND or } V_{CC}$		0.13	0.55		0.55	V	
I_I	Input leakage current 74ABT16373B	$V_{CC} = 5.5\text{V}; V_I = V_{CC} \text{ or GND}$		± 0.01	± 1		± 1	μA	
I_I	Input leakage current 74ABTH16373B	$V_{CC} = 5.5\text{V}; V_I = V_{CC} \text{ or GND}$	Control pins	± 0.01	± 1		± 1	μA	
		$V_{CC} = 5.5\text{V}; V_I = V_{CC}$	Data pins ⁵	0.01	1		1	μA	
		$V_{CC} = 5.5\text{V}; V_I = 0$		-1	-3		-5	μA	
I_{HOLD}	Bus Hold current A inputs ⁶ 74ABTH16373B	$V_{CC} = 4.5\text{V}; V_I = 0.8\text{V}$		50			50	μA	
		$V_{CC} = 4.5\text{V}; V_I = 2.0\text{V}$		-75			-75		
		$V_{CC} = 5.5\text{V}; V_I = 0 \text{ to } 5.5\text{V}$		± 800					
I_{OFF}	Power-off leakage current	$V_{CC} = 0.0\text{V}; V_O \text{ or } V_I \leq 4.5\text{V}$		± 5.0	± 100		± 100	μA	
I_{PU}/I_{PD}	Power-up/down 3-State output current ⁴	$V_{CC} = 2.1\text{V}; V_O = 0.5\text{V}; V_I = \text{GND or } V_{CC}; V_{OE} = \text{GND}$		± 5.0	± 50		± 50	μA	
I_{OZH}	3-State output High current	$V_{CC} = 5.5\text{V}; V_O = 5.5\text{V}; V_I = V_{IL} \text{ or } V_{IH}$		0.5	10		10	μA	
I_{OZL}	3-State output Low current	$V_{CC} = 5.5\text{V}; V_O = 0.0\text{V}; V_I = V_{IL} \text{ or } V_{IH}$		-0.5	-10		-10	μA	
I_O	Output current ¹	$V_{CC} = 5.5\text{V}; V_O = 2.5\text{V}$	-50	-70	-180	-50	-180	mA	
I_{CEX}	Output High leakage current	$V_{CC} = 5.5\text{V}; V_O = 5.5\text{V}; V_I = \text{GND or } V_{CC}$		0.1	50		50	μA	
I_{CCH}	Quiescent supply current	$V_{CC} = 5.5\text{V}; \text{Outputs High, } V_I = \text{GND or } V_{CC}$		0.5	2		2	mA	
I_{CCL}		$V_{CC} = 5.5\text{V}; \text{Outputs Low, } V_I = \text{GND or } V_{CC}$		8	19		19	mA	
I_{CCZ}		$V_{CC} = 5.5\text{V}; \text{Outputs 3-State; } V_I = \text{GND or } V_{CC}$		0.5	2		2	mA	
ΔI_{CC}	Additional supply current per input pin ² 74ABT16373B	$V_{CC} = 5.5\text{V}; \text{one input at } 3.4\text{V, other inputs at } V_{CC} \text{ or GND}$		5	100		100	μA	
ΔI_{CC}	Additional supply current per input pin ² 74ABTH16373B	$V_{CC} = 5.5\text{V}; \text{one input at } 3.4\text{V, other inputs at } V_{CC} \text{ or GND}$		0.5	1.5		1.5	mA	

NOTES:

1. Not more than one output should be tested at a time, and the duration of the test should not exceed one second.
2. This is the increase in supply current for each input at 3.4V.
3. For valid test results, data must not be loaded into the flip-flops (or latches) after applying the power.
4. This parameter is valid for any V_{CC} between 0V and 2.1V, with a transition time of up to 10msec. From $V_{CC} = 2.1$ to $V_{CC} = 5\text{V} \pm 10\%$ a transition time of up to 100 μsec is permitted.
5. Unused pins at V_{CC} or GND.
6. This is the bus hold overdrive current required to force the input to the opposite logic state.

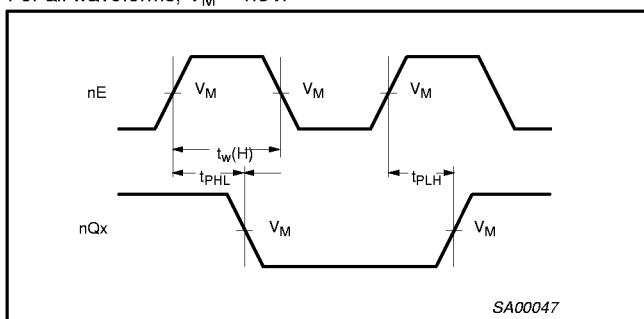
16-bit transparent latch (3-State)

74ABT16373B
74ABTH16373B**AC CHARACTERISTICS**GND = 0V, $t_R = t_F = 2.5\text{ns}$, $C_L = 50\text{pF}$, $R_L = 500\Omega$

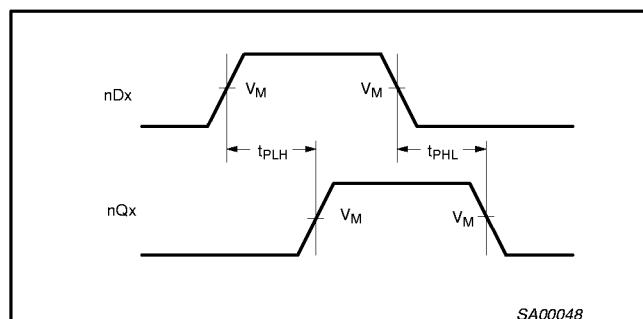
SYMBOL	PARAMETER	WAVEFORM	LIMITS					UNIT	
			$T_{amb} = +25^\circ\text{C}$ $V_{CC} = +5.0\text{V}$			$T_{amb} = -40 \text{ to } +85^\circ\text{C}$ $V_{CC} = +5.0\text{V} \pm 0.5\text{V}$			
			MIN	TYP	MAX	MIN	MAX		
t_{PLH} t_{PHL}	Propagation delay nDx to nQx	2	1.5 1.1	2.5 2.0	3.8 3.1	1.5 1.1	4.4 3.8	ns	
t_{PLH} t_{PHL}	Propagation delay nE to nQx	1	1.6 1.3	2.5 2.1	3.8 3.1	1.6 1.3	4.4 3.6	ns	
t_{PZH} t_{PZL}	Output enable time to High and Low level	4 5	1.2 1.3	2.3 2.3	3.5 3.5	1.2 1.3	4.6 4.5	ns	
t_{PHZ} t_{PLZ}	Output disable time from High and Low level	4 5	1.9 1.7	3.1 2.6	4.5 3.8	1.9 1.7	5.3 4.2	ns	

AC SETUP REQUIREMENTSGND = 0V, $t_R = t_F = 2.5\text{ns}$, $C_L = 50\text{pF}$, $R_L = 500\Omega$

SYMBOL	PARAMETER	WAVEFORM	LIMITS			UNIT
			$T_{amb} = +25^\circ\text{C}$ $V_{CC} = +5.0\text{V}$		$T_{amb} = -40 \text{ to } +85^\circ\text{C}$ $V_{CC} = +5.0\text{V} \pm 0.5\text{V}$	
			MIN	TYP	MIN	
$t_s(H)$ $t_s(L)$	Setup time, High or Low nDx to nE	3	1.0 1.0	0.0 0.3	1.0 1.0	ns
$t_h(H)$ $t_h(L)$	Hold time, High or Low nDx to nE	3	0.5 0.5	-0.2 0.0	0.5 0.5	ns
$t_w(H)$	Enable pulse width High	1	2.5	1.0	2.5	ns

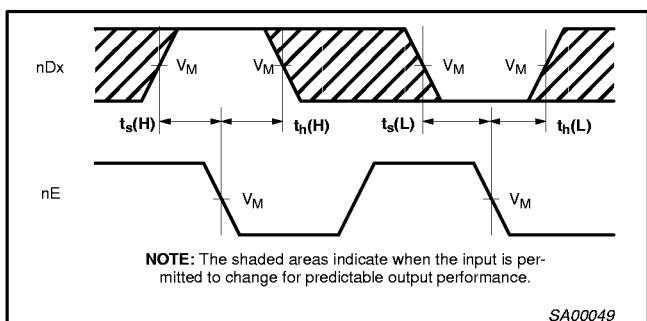
AC WAVEFORMSFor all waveforms, $V_M = 1.5\text{V}$.

Waveform 1. Propagation Delay, Enable to Output, and Enable Pulse Width

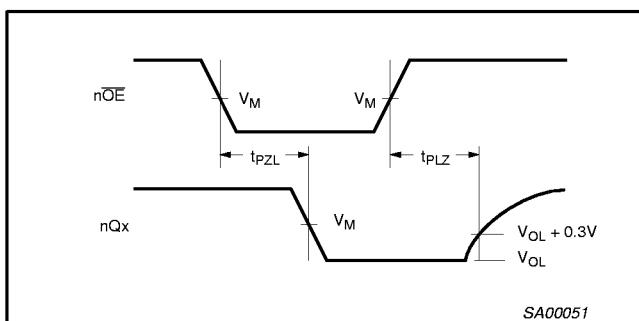


Waveform 2. Propagation Delay for Data to Outputs

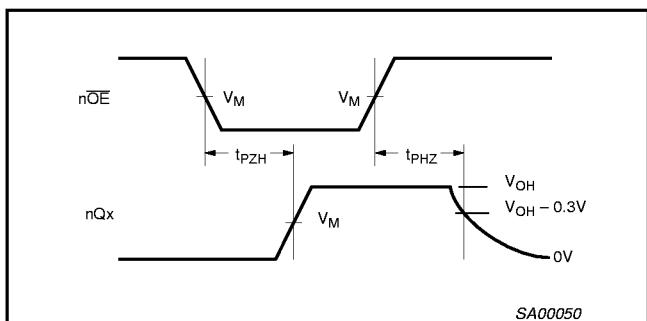
16-bit transparent latch (3-State)

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Waveform 3. Data Setup and Hold Times

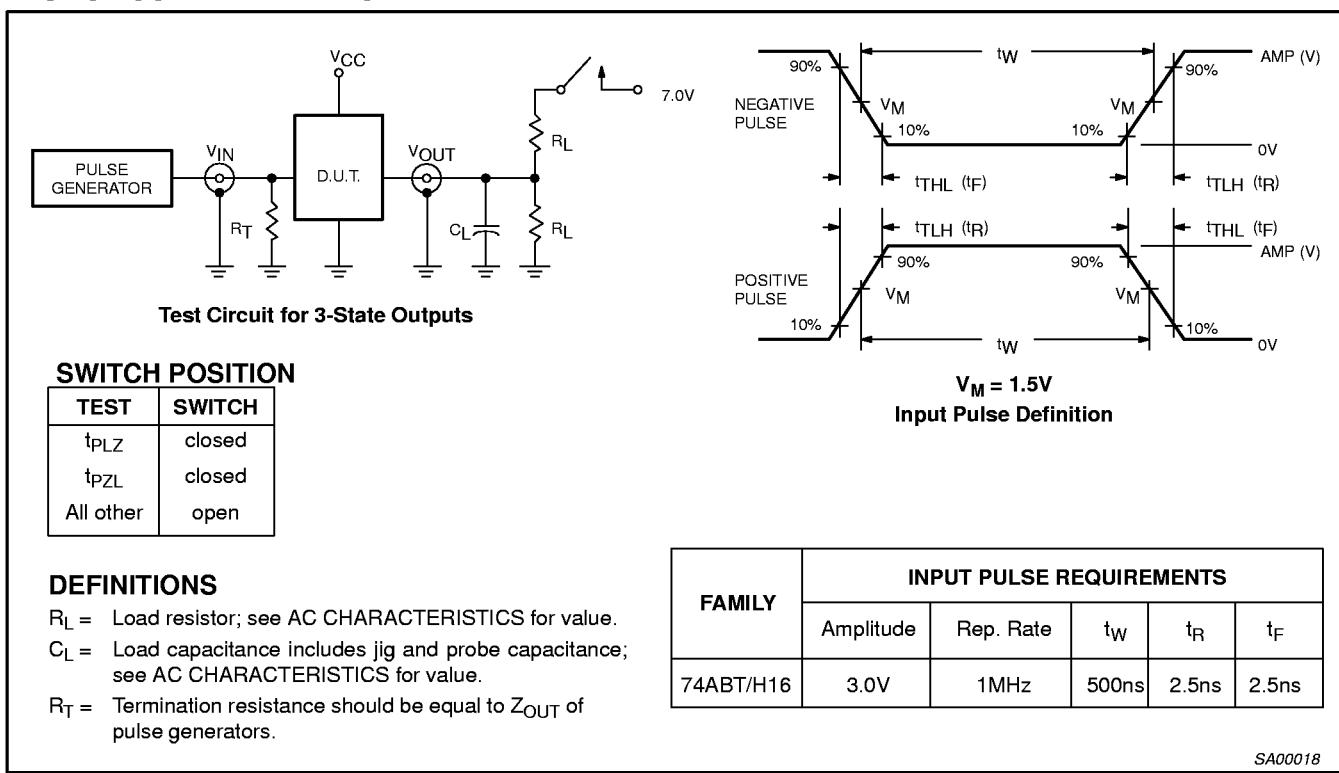


Waveform 5. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level



Waveform 4. 3-State Output Enable Time to High Level and Output Disable Time from High Level

TEST CIRCUIT AND WAVEFORM

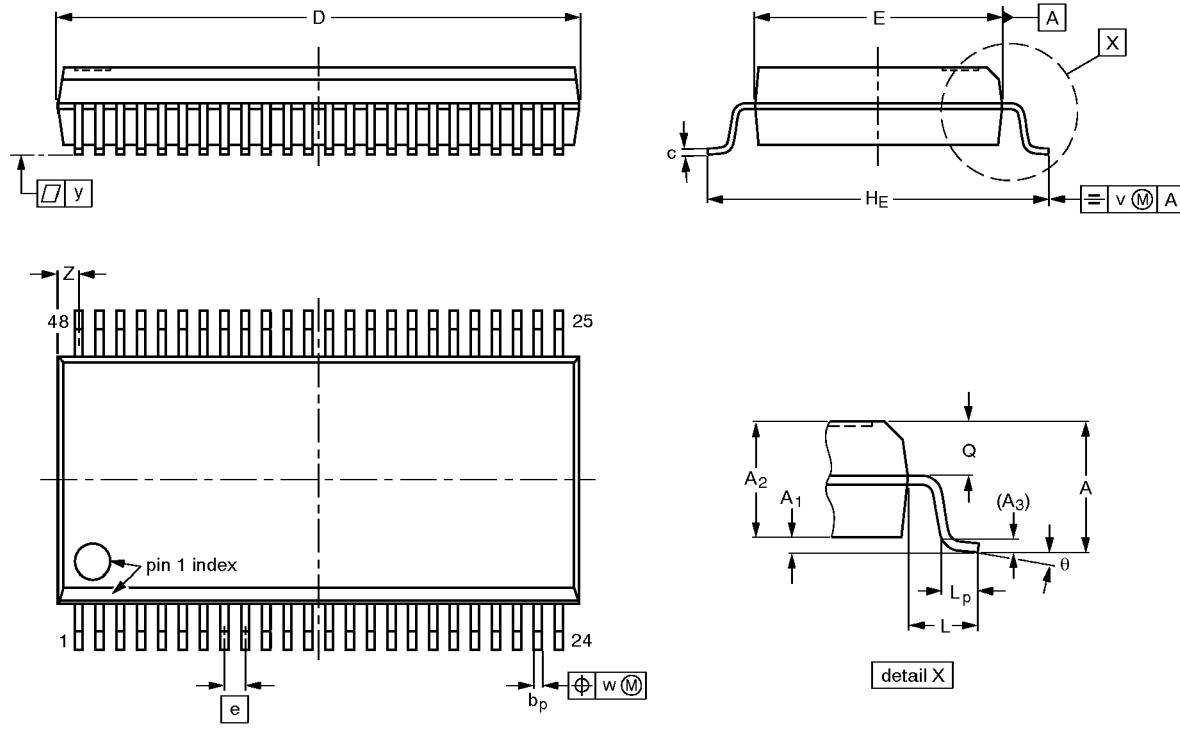


16-bit transparent latch (3-State)

74ABT16373B
74ABTH16373B

SSOP48: plastic shrink small outline package; 48 leads; body width 7.5 mm

SOT370-1



0 5 10 mm
scale

DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	b _p	c	D ⁽¹⁾	E ⁽¹⁾	e	H _E	L	L _p	Q	v	w	y	z ⁽¹⁾	θ
mm	2.8 0.2	0.4 0.2	2.35 2.20	0.25	0.3 0.2	0.22 0.13	16.00 15.75	7.6 7.4	0.635	10.4 10.1	1.4	1.0 0.6	1.2 1.0	0.25	0.18	0.1	0.85 0.40	8° 0°

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

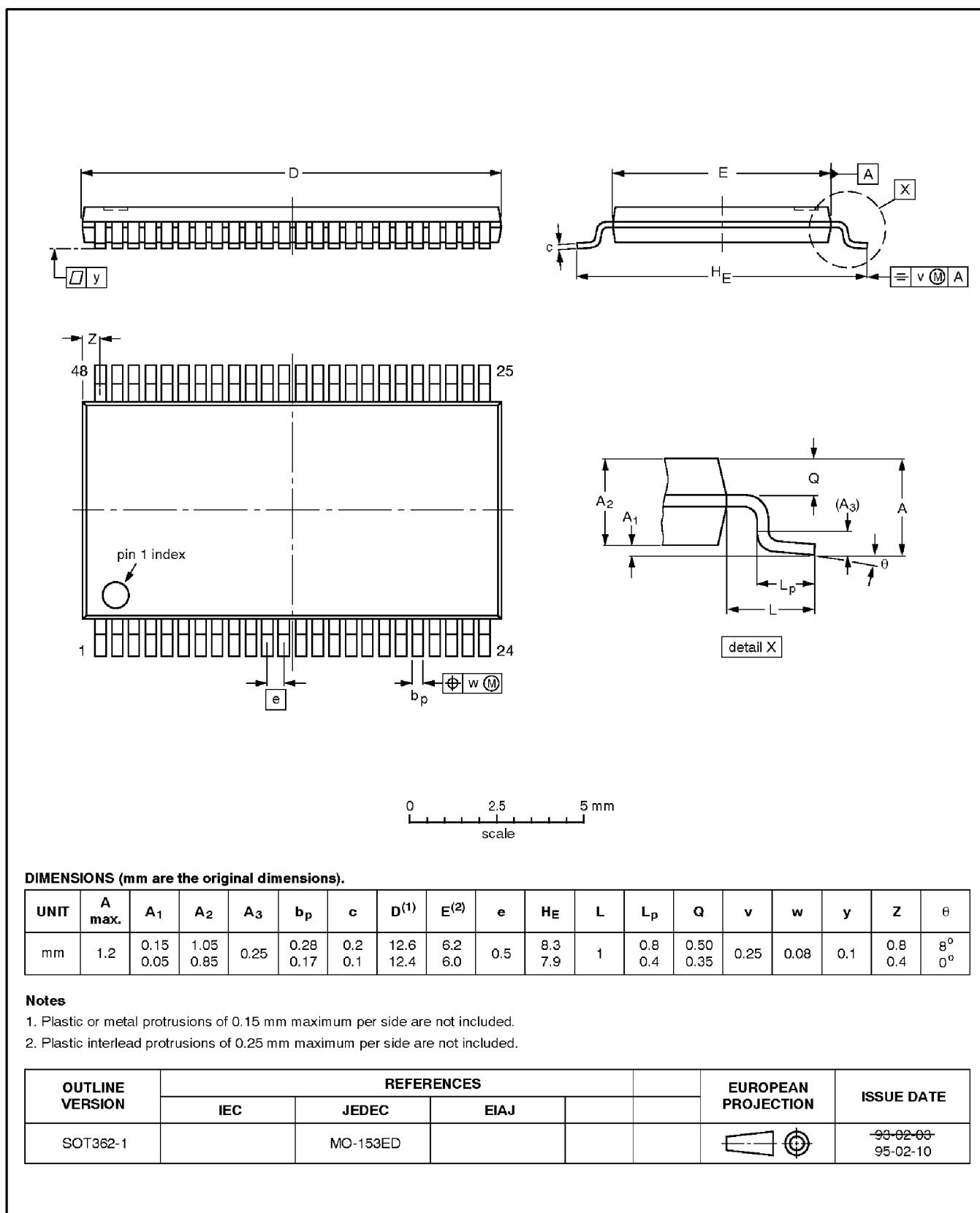
OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT370-1		MO-118AA				93-11-02 95-02-04

16-bit transparent latch (3-State)

74ABT16373B
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TSSOP48: plastic thin shrink small outline package; 48 leads; body width 6.1mm

SOT362-1



DIMENSIONS (mm are the original dimensions).

UNIT	A max.	A ₁	A ₂	A ₃	b _p	c	D ⁽¹⁾	E ⁽²⁾	e	H _E	L	L _p	Q	v	w	y	z	theta
mm	1.2 0.05	0.15 0.85	1.05 0.25	0.25 0.17	0.28 0.17	0.2 0.1	12.6 12.4	6.2 6.0	0.5	8.3 7.9	1	0.8 0.4	0.50 0.35	0.25 0.08	0.08 0.1	0.8 0.4	8° 0°	

Notes

- Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT362-1		MO-153ED				-99-02-00 95-02-10